Search Notes

Application/Control No.	Applicant(s)/Patent under Reexamination
10/663,903	SASAKI, YOSHITAKA
Examiner	Art Unit
Paul D. Kim	3729

	SEAR	CHED	
Class	Subclass	Date	Examiner
29	603.11 603.13- 603.16 603.18	6/30/2005	PK
360	126 317	6/30/2005	PK
183.51			

INT	INTERFERENCE SEARCHED		
Class	Subclass	Date	Examiner
	<u> </u>		

SEARCH NOTES (INCLUDING SEARCH STRATEGY)			
	DATE	EXMR	
Reviewed Parent Application 09/708628 (US PAT. 6,657,815)	6/30/2005	PK	
Text Search EAST/NPL (IEEE)	6/30/2005	PK	
Updated Text Search EAST	12/23/2005	PK	
	2001		